NX5P3363/Q100 USB PD and Type-C current-limited power switch

Rev. 1.0 — 31 May 2024

1 General description

The NX5P3363/Q100 is a precision adjustable current-limited power switch for USB PD application. The device includes undervoltage lockout, overtemperature protection, and reverse current protection circuits to automatically isolate the switch terminals when a fault condition occurs. The 29 V tolerance on VBUS pin ensures the device is able to work on a USB PD port; a current limit input (ILIM) pin defines the overcurrent limit threshold; an open-drain fault output (FLT) indicates when a fault condition has occurred.

The overcurrent limit threshold can be programmed from 400 mA to 3.3 A, using an external resistor between the ILIM pin and GND pin. In the overcurrent condition, the device clamps the output current to the value set by ILIM and keeps the switch on while asserting the FLT flag.

To minimize current surges during normal turn on, the device has built-in soft start by limiting the power switch turn on slew rate. However, user can disable the soft start and request a fast output by pulling FO pin HIGH.

A fast recovery reverse current protection (RCP) circuit has been added to the switch to prevent reverse current flowing back to power source at all times. When exiting from reverse current protection state, the power MOSFET turns on within 50 μ s. The fast RCP recovery ensures the voltage on VBUS doesn't drop too much in a power source swap application.

NX5P3363/Q100 is offered in a 2.2 x 2.2 mm, 16 bump WLCSP package.

2 Features and benefits

- VIN supply voltage range from 4.0 V to 5.5 V
- · All time reverse current protection with ultra fast RCP recovery
- Adjustable current limit from 400 mA to 3.3 A
- · Clamped current output in overcurrent condition
- 29 V high voltage tolerance on VBUS pin
- Low ON resistance of the power FETs: 35 m Ω (typical) in total
- Surge protection: IEC61000-4-5 exceeds ±80 V on VBUS
- Over temperature protection
- Qualified in accordance with AEC-Q100 Grade 3 compliance
- · Safety approvals
 - UL 62368-1, 2nd edition, file no. 20170804-E470128
 - IEC 62368-1, 2nd edition, file no. DK-65509-UL
- ESD protection
 - IEC61000-4-2 contact discharge exceeds 8 kV on VBUS
 - HBM ANSI/ESDA/JEDEC JS-001 Class 2 exceeds 2 kV
 - CDM AEC standard Q100-01 (JESD22-C101E) exceeds 500 V
- Specified from -40 °C to +85 °C ambient temperature



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3 Applications

- Notebook, ultrabook and desktop
- USB PD and Type C port/hubs
- Tablet and smart phone

4 Ordering information

Table 1. Ordering information

| Type number | Topside marking | Package | | | | |
|-----------------|--------------------|---------|---|-----------|--|--|
| | | Name | Description | Version | | |
| NX5P3363UK/Q100 | X5PT7 | | wafer level chip-scale package; 16 bumps; 2.2 x 2.2 mm x 0.555 mm (backside coating included) | SOT1394-3 | | |

4.1 Ordering options

Table 2. Ordering options

| Type number | Orderable part number | Package | J | Minimum order quantity | Temperature |
|-----------------|--------------------------|---------|---|---------------------------|------------------------------|
| NX5P3363UK/Q100 | NX5P3363UKZ/Q100 | | REEL 7" Q1/T1 *SPECIAL MARK CHIPS DP | 3000 | T_{amb} = -40 °C to +85 °C |

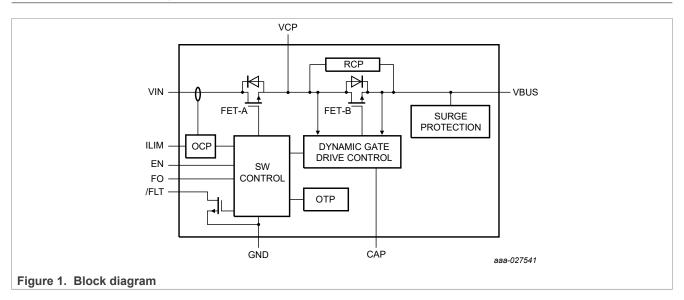
5 Marking

Table 3. Marking

| Line | Marking | Description |
|------|---------|--|
| A | X5PT7 | basic type name |
| В | mmmmmnn | wafer lot code (mmmmmm) and wafer number (nn) |
| С | | manufacturing code: X = foundry location t = assembly location D = RoHS code (dark green) YY = assembly year code WW = assembly week code |

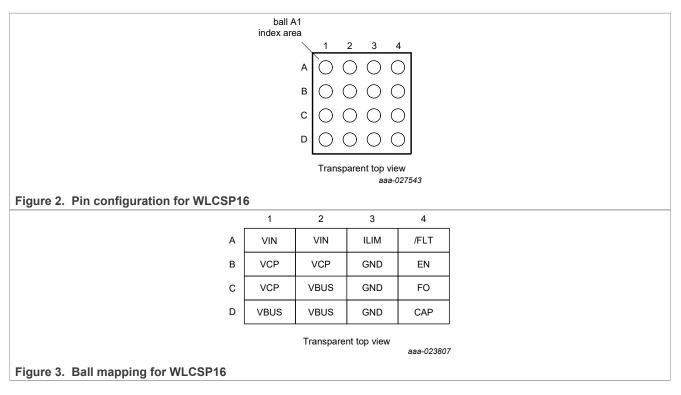
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6 Functional diagram



7 Pinning information

7.1 Pinning



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7.2 Pin description

Table 4. Pin description

| Symbol | Pin | Description |
|--------|------------|---|
| VIN | A1, A2 | Input voltage |
| VCP | B1, B2, C1 | Central point of two power MOSFETs |
| VBUS | C2, D1, D2 | Output voltage |
| ILIM | A3 | Current limiter. Connect a resistor to GND to adjust the current limit level |
| FLT | A4 | Fault condition indicator (open-drain output) |
| EN | B4 | Enable input (active HIGH with internal 1 M Ω pull down resister) |
| GND | B3, C3, D3 | Ground (0 V) |
| FO | C4 | Fast turn on. Pull this pin HIGH to enable fast turn-on feature. 1 $M\Omega$ pull down resister integrated. |
| CAP | D4 | Connect a capacitor to GND |

8 Functional description

Table 5. Function table

H = HIGH voltage level; L = LOW voltage level

| EN | FO | VIN | FLT | Main Power Switch |
|----|----|--------------------------------|-----|---|
| х | Х | < 4.0 V | Z | under voltage lockout, Switch open |
| L | X | 4.0 V to 5.5 V | Z | disabled; switch open |
| Н | L | 4.0 V to 5.5 V | Z | enabled; switch turns on with slew rate control |
| Н | Н | 4.0 V to 5.5 V | Z | enabled; switch turns on without slew rate control; fast turn on |
| Н | X | 4.0 V to 5.5 V | L | In current limit condition or over temperature protection |
| х | Х | 4.0 V to 5.5 V and VIN <= VBUS | Z | Reverse protection; switch open |

8.1 EN input

When the EN is set LOW, all the FETs are disabled, and the device enters low-power mode disabling all protection circuits and setting the FLT output high impedance. When EN is set HIGH, all protection circuits are enabled and then, if no fault condition exists, the main power MOSFETs turn on.

8.2 Fast recovery RCP

NX5P3363/Q100 uses dynamic gate drive control loop to implement reverse-current protection. During normal operation, device always tries to regulate the VBUS output voltage to be VIN - 70 mV.

When the load current produces a drop voltage greater than 70 mV, the gate control loop drives the power MOS to lower its R_{DSon} to try to achieve the 70 mV. In the heavy load condition, the gate control loop keeps increasing the gate driving current of the MOSFET until it is fully on and remains fully on if the voltage drop at that time still exceeds 70 mV.

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In light load condition, when the drop voltage is below 70 mV, the gate control loop reduces the gate driving current to increase the R_{DSon} to try to achieve the 70 mV drop voltage, which leads to the complete shutdown of the power MOSFET in reverse voltage condition.

If VBUS voltage is higher than VIN when enabling the device, the power MOSFET never turns on. The device always does a pre-check before switching on the power MOSFETs.

In the RCP state, EN is HIGH; when the VBUS drops below VIN, the device exits the RCP state and turns on the power FET again within 50 μ S. The fast recovery of the power MOSFET is assisted by the external boost capacitor at CAP pin. The boost capacitor is charged whenever EN is pulled HIGH.

The input voltage level of FO pin has nothing to do with RCP recovery time.

8.3 VBUS hot plug-in RCP

The RCP circuit, together with dynamic gate drive control circuit, acts like an "ideal diode". This protects the VIN lifting from reverse current when VBUS has a hot plug-in during the following conditions and limits the VIN voltage lift < 400 mV. Refer to NX5P3363/Q100 ground pin.

- VBUS < 24 V, plug-in when NX5P3363/Q100 is on
- C_{IN} is in the range of 57 μ F to 100 μ F
- C_{BUS} is in the range of 10 μ F to 22 μ F

If the VBUS, C_{IN}, C_{BUS} are not in the range or conditions, there may be more reverse current and the VIN voltage lift depends on the conditions.

8.4 Fast Turn ON

In order to reduce the power on inrush current, NX5P3363/Q100 deploys slew rate control for normal turn on; there is approximately 2 ms rising time. However, in the fast role swap application, fast turn on is requested. The customer achieves this by pulling FO pin HIGH. By doing this, rise time is reduced to the 100 μ S level. There is an internal 1 M Ω pull-down resister on this pin. The fast turn on is achieved by turn off short circuit protection and OCP feature in the fast start stage; typically 220 μ s. It is recommended to add a 10 μ F capacitor close to VIN pin to limit the inrush current in fast turn on mode.

The feature only applies to fast role swap, and FO pin should be controlled by USB PD PHY. When a fast role swap event is detected by USB PD PHY, the FO pin should pull HIGH first, then enable the EN pin of NX5P3363/Q100 when the FRS is requested. Depending on the voltage on VBUS, there are two scenarios:

- V(VBUS) > V(VIN): The switch enters RCP mode. Once the voltage on VBUS drops below VIN voltage, switch immediately turns on within 50 μS.
- 2. $V(VBUS) \le V(VIN)$

The switch performs a fast turn ON as the FO is HIGH; the turn on time is 150 μ S.

When fast role swap is finished and NX5P3363/Q100 is in all the other conditions, FO pin should remain LOW to limit the inrush current.

8.5 Undervoltage lockout

Independently of the logic level on the EN pin, the undervoltage lockout (UVLO) circuit disables the N-channel MOSFET and enters low power mode until the input voltage reaches the UVLO turn-on threshold VUVLO.

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8.6 ILIM

The overcurrent protection circuit's (OCP) trigger value I_{OCP} can be set using an external resistor R_{ILIM} connected between ILIM pin and GND pin. When EN is set HIGH and the ILIM pin is grounded, the N-channel MOSFET is disabled. The I_{OCP} setting is given in <u>Table 12</u>.

8.7 Main power FET overcurrent protection (OCP)

The device offers overcurrent protection when enabled. The three possible overcurrent conditions that can occur are:

- 1. Overcurrent at startup: $I_{SW} > I_{OCP}$ when enabling the N-channel MOSFET.
- 2. Overcurrent when enabled: $I_{SW} > I_{OCP}$ when the N-channel MOSFET is enabled.
- 3. Short circuit when enabled: I_{SW} exceeds short circuit conditions

In the overcurrent condition, because the device clamps the output current rather than the switch, the power dissipation on the device might be increased which could lead to overtemperature protection (see <u>Section 8.9</u>).

8.7.1 Overcurrent at startup

If the device senses a VBUS short to GND or overcurrent while enabling the N-channel MOSFET, OCP is triggered. It limits the output current to I_{OCP} and after the deglitch time sets the FLT output LOW.

8.7.2 Overcurrent when enabled

If the device senses I_{SW} exceeds I_{OCP} when enabled, OCP is triggered. It limits the output current to I_{OCP} and after the deglitch time sets the FLT output LOW. As a consequence, limiting the output current reduces $V_{O(VBUS)}$.

8.7.3 Short circuit when enabled

If the current through switch exceeds 7.5 A (typical), the short circuit protection is triggered. That disables the N-channel MOSFET immediately. It then enables the N-channel MOSFET again; output current is limited to I_{OCP} and after the deglitch time the FLT output is set LOW. Thermal protection is triggered due to the big power consumption on the device.

In the customer specific application case, the short circuit protection ensures the VIN voltage stays above 4.5 V at the following short circuit testing.

- C_{IN} = 57 µF, VBUS short to GND directly by a metal tweezer; this means the short resistor to ground is typically 40 m Ω
- VIN connected to customer specified DC-DC

8.8 FLT output

The FLT output is an open-drain output that requires an external pull-up resistor. The FLT output is set LOW to indicate an OCP or OTP condition has occurred. The FLT output returns to the high impedance state automatically once the fault condition is removed. An internal 8 ms deglitch circuit for the overcurrent protection is used when entering fault conditions. Overtemperature condition doesn't have deglitch time, and the FLT signal is asserted immediately. The RCP circuit won't trigger FLT signal.

8.9 Overtemperature protection

If the device temperature exceeds 140 °C when EN is set HIGH, the overtemperature protection (OTP) circuit disables the Power MOSFET and indicates a fault condition by setting the FLT pin LOW. Any transition on the

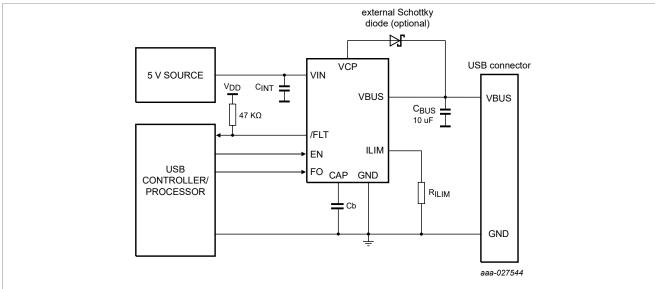
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EN pin has no effect. Once the device temperature decreases to below 115 °C the device returns to the defined state.

In the overcurrent limiting condition, the increased power dissipation on the device results in OTP, especially in the output-short-to-GND error.

9 Application diagram



A 0.1 μ F ceramic capacitor (C_{INT}) is required for local decoupling. Higher capacitor values C_{INT} further reduce the voltage drop at the input. When driving inductive loads, a larger capacitance C_{INT} prevents voltage spikes from exceeding absolute maximum voltage of VIN. The CBUS capacitor should be placed as closer as possible to VBUS pin.

The recommended Cb is 1 nF with at least 16 V voltage tolerance.

The external Schottky diode is optional; NX5P3363/Q100 works well without it. To improve the lowest VBUS voltage during fast role swap, it is recommended to add a lower forward voltage diode, for example VF = 0.3 V.

Figure 4. Application diagram

10 Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | | Min | Мах | Unit |
|------------------------|-------------------------|--|-----|------|-----|------|
| VI | input voltage | VBUS | [1] | -0.5 | +29 | V |
| | | VIN; VCP; ILIM; EN; FO | [1] | -0.5 | +6 | V |
| | | САР | [1] | -0.5 | +12 | V |
| | peak voltage tolerance | VBUS; 20 µs pulse width, 1 s interval | [1] | -0.5 | +34 | V |
| Vo | output voltage | FLT | [1] | -0.5 | +6 | V |
| l _{IK} | input clamping current | input EN: V _{I(EN)} < -0.5 V | | -50 | - | mA |
| I _{I(source)} | input source current | input ILIM | | - | 1 | mA |
| I _{SK} | switch clamping current | input VIN: V _{I(VIN)} < -0.5 V | | -50 | - | mA |
| | | output VOUT: V _{O(VBUS)} < -0.5 V | | -50 | - | mA |

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Table 6. Limiting values...continued

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|---------------------|--------------------------------------|--------------------------|-----|-----|------|------|
| I _{SW} | Main Power switch continuous current | V _{SW} > -0.5 V | [2] | - | 3.6 | A |
| T _{j(max)} | maximum junction temperature | | | -40 | +125 | °C |
| T _{stg} | storage temperature | | | -65 | +150 | °C |
| P _{tot} | total power dissipation | | [3] | - | 1.7 | W |

[1] The minimum input voltage rating may be exceeded if the input current rating is observed.

[2] Internally limited.

[3] The (absolute) maximum power dissipation depends on the junction temperature T_j. Higher power dissipation is allowed in conjunction with lower ambient temperatures. The conditions to determine the specified values are T_{amb} = 25 °C and the use of a two layer PCB.

11 Recommended operating conditions

Table 7. Recommended operating conditions

| Symbol | Parameter | Conditions | Min | Max | Unit |
|----------------------|--------------------------|------------------------------|------|-----|------|
| VI | input voltage | VIN | 4.0 | 5.5 | V |
| | | EN; FO | 0 | 5.5 | V |
| | | VBUS (OFF state) | 0 | 23 | V |
| Vo | Output voltage | VBUS; FLT | 0 | 5 | V |
| I _{SW} | switch current | T_{amb} = -40 °C to +85 °C | 0 | 3 | A |
| I _{O(sink)} | output sink current | FLT | 0 | 10 | mA |
| R _{ILIM} | current limit resistance | ILIM pin to GND | 14.3 | 140 | kΩ |
| C _{Bus} | VBUS output capacitance | VBUS to GND | 10 | 100 | μF |
| T _{amb} | ambient temperature | | -40 | +85 | °C |

12 Thermal characteristics

Table 8. Thermal characteristics

| Symbol | Parameter | Conditions | | Тур | Unit |
|----------------------|---|------------|-----|------|------|
| R _{th(j-a)} | thermal resistance from junction to ambient | | [1] | 58.4 | K/W |

[1] R_{th(j-a)} is dependent upon board layout. To minimize R_{th(j-a)}, ensure all pins have a solid connection to larger copper layer areas. In multi-layer PCBs, the second layer should be used to create a large heat spreader area below the device. Avoid using solder-stop varnish under the device.

13 Static characteristics

Table 9. Static characteristics

At recommended operating conditions; $V_{I(VIN)} = V_{I(EN)}$, $R_{FAULT} = 10 \text{ k}\Omega$ unless otherwise specified; Voltages are referenced to GND (ground = 0 V). See <u>Figure 9</u>

| Symbol | Parameter | Conditions | Min | Typ ^[1] | Мах | Unit |
|-----------------|-----------------------------|---|-----|--------------------|-----|------|
| V _{IH} | HIGH-level input voltage | EN; FO; V _{I(VIN)} = 4.0 V to 5.5 V; | 1.2 | - | - | V |

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| Table 9. Static characteristicscontinued | |
|--|--|
|--|--|

At recommended operating conditions; $V_{I(VIN)} = V_{I(EN)}$, $R_{FAULT} = 10 \text{ k}\Omega$ unless otherwise specified; Voltages are referenced to GND (ground = 0 V). See <u>Figure 9</u>

| Symbol | Parameter | Conditions | | Min | Typ ^[1] | Max | Unit |
|------------------------|--|---|---------|-----|--------------------|---|------|
| V _{IL} | LOW-level input voltage | EN; FO; V _{I(VIN)} = 4.0 V to 5.5 V; | | - | - | 0.4 | V |
| lı | input leakage current | EN; FO; V _{I(VIN)} = 5.0 V; | | - | - | 7 | μA |
| I _(VIN) | supply current | VBUS open; V _{I(VIN)} = 5.0 V | | | | | |
| | | EN = GND (low power mode); | | - | 3 | 55 | μA |
| | | EN = $V_{I(VIN)}$; R _{ILIM} = 33 kΩ | | - | 1.3 | 1.7 | mA |
| | | EN = $V_{I(VIN)}$; R _{ILIM} = 16 kΩ | | - | 1.35 | 0.4 7 55 | mA |
| I _{S(OFF)} | VBUS OFF-State leakage current | $V_{I(VIN)}$ = 5.0 V; $V_{I(VBUS)}$ = 0 V; EN = LOW | [2] | | -0.1 | - | μA |
| l | VIN OFF-state | V _{I(VBUS)} = 5.0 V; V _{I(VIN)} = 0 V; EN = LOW | [2] | -2 | -0.1 | - | μA |
| l | leakage current | V _{I(VBUS)} = 20 V; V _{I(VIN)} = 0 V; EN = LOW | [2] | -2 | -0.1 | 1.7 1.7 - | μA |
| I _{S(ON)} | FET-B leakage current in RCP | V _{I(VIN)} = 5 V; V _{I(VBUS)} = 20 V; EN = 5 V | [2] [3] | -2 | -0.1 | - | μA |
| R _{pd} | Pull-down resistance | EN; FO; V _{I(VIN)} = 5 V | | - | 1 | - | MΩ |
| V _{UVLO} | under voltage lockout voltage | VIN pin | | - | 3.6 | 3.8 | V |
| V _{hys(UVLO)} | under voltage lockout hysteresis voltage | | | - | 100 | - | mV |
| V _{OL} | LOW-level output voltage | FLT; I _O = 4 mA | | - | - | 0.3 | V |
| C _{I(EN)} | EN pin | | | - | 3 | - | pF |
| C _{I(FO)} | FO pin | | | - | 4 | - | pF |
| | 1 | 1 | | | | | |

[1] Typical values are measured at $T_i = 25 \text{ °C}$.

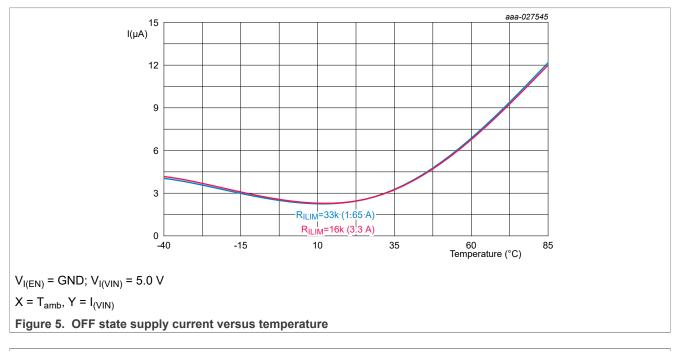
[2] Currents are defined with respect to conventional current flow into the respective terminal. Negative value means the current flows out of the respective terminal of the chip.

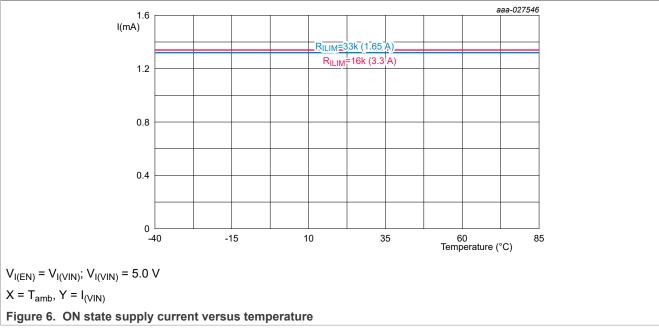
[3] Guaranteed by design

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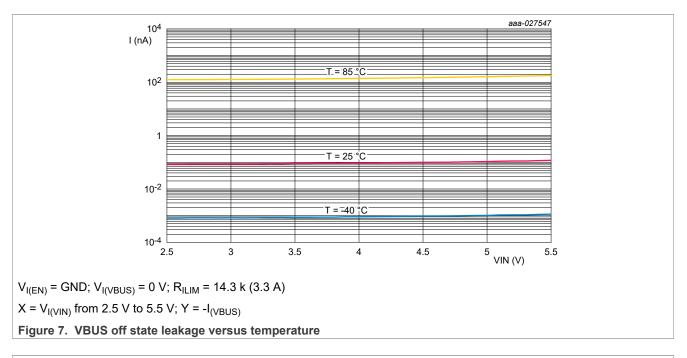
13.1 Graphs

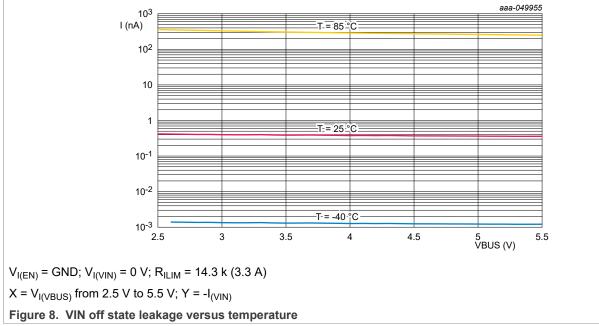




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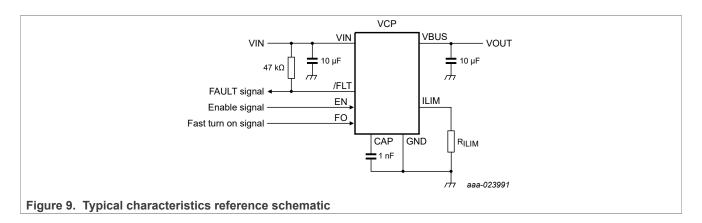
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13.2 Thermal shutdown

Table 10. Thermal shutdown

 $V_{I(VIN)} = V_{I(EN)}$, $R_{FAULT} = 10 \ k\Omega$ unless otherwise specified; Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | Min | Тур | Мах | Unit |
|-------------------------|---|-------------------------------|-----|-----|-----|------|
| T _{th(ots)} | over temperature shutdown threshold temperature | $V_{I(VIN)}$ = 4.0 V to 5.5 V | - | 140 | - | °C |
| T _{th(otp)hys} | hysteresis of over temperature protection threshold temperature | $V_{I(VIN)}$ = 4.0 V to 5.5 V | - | 25 | - | °C |

13.3 ON resistance

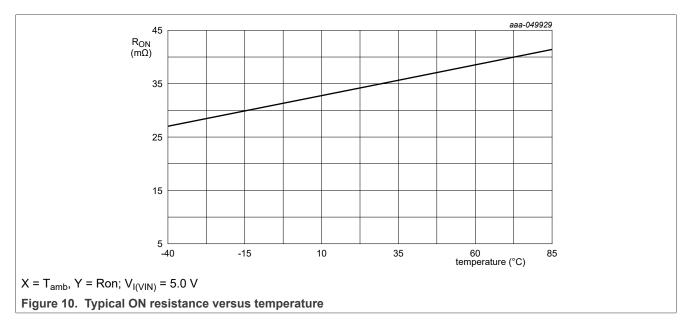
Table 11. ON resistance

 $V_{I(VIN)} = V_{I(EN)}$, $R_{FAULT} = 10 \ k\Omega$ unless otherwise specified; Voltages are referenced to GND (ground = 0 V). See <u>Figure 9</u>

| Symbol | Parameter | Conditions | Min | Тур | Мах | Unit |
|-----------------|-----------|---|-----|-----|-----|------|
| R _{ON} | | R _{FETA} + R _{FETB} ; V _{I(VIN)} = 4.0 to 5.5 V; see <u>Figure 10</u> | | | | |
| | | T _{amb} = 25 °C | - | 35 | 42 | mΩ |
| | | T _{amb} = -40 °C to +85 °C | - | - | 49 | mΩ |

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13.4 ON resistance graphs



13.5 Current limit

Table 12. Current limit

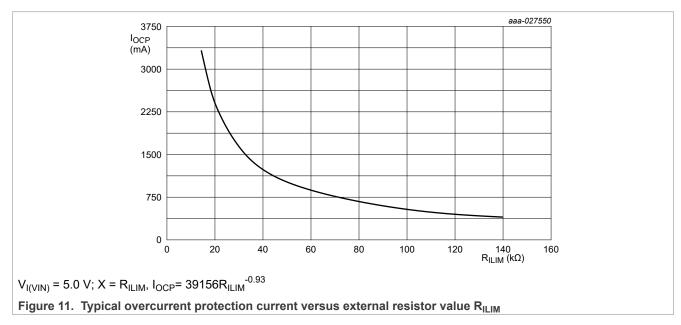
 $V_{I(VIN)} = V_{I(EN)}$, $R_{FAULT} = 10 \ k\Omega$ unless otherwise specified; Voltages are referenced to GND (ground = 0 V). See <u>Figure 9</u>

| Symbol | Parameter | Conditions | Min | Typ ^[1] | Max | Unit |
|---|-----------------------------------|--|------|--------------------|------|------|
| I _{OCP} overcurrent protection current | overcurrent protection current | V _{I(VIN)} = 4.0 to 5.5 V; T _{amb} = -40 °C to +85 °C; see <u>Figure 11</u> , | | | | |
| | | R _{ILIM} = 140 kΩ | 330 | 400 | 465 | mA |
| | | R _{ILIM} = 97.6kΩ | 480 | 550 | 625 | mA |
| | | R _{ILIM} = 51 kΩ | 915 | 1000 | 1107 | mA |
| | | R _{ILIM} = 30 kΩ | 1505 | 1640 | 1780 | mA |
| | | R _{ILIM} = 22.1 kΩ | 2024 | 2200 | 2398 | mA |
| | | R _{ILIM} = 18.2kΩ | 2450 | 2640 | 2820 | mA |
| | | R _{ILIM} = 14.3 kΩ | 3100 | 3300 | 3531 | mA |
| | | ILIM shorted to VIN | 168 | 210 | 273 | mA |

[1] 1% tolerance resistor is recommend for $\mathsf{R}_{\mathsf{ILIM}}$

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13.6 Current limit graphs



14 Dynamic characteristics

Table 13. Dynamic characteristics

At recommended operating conditions; $V_{I(VIN)} = V_{I(EN)}$, $R_{FAULT} = 10 \text{ k}\Omega$ unless otherwise specified; voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | | Min | Typ ^[1] | Max | Unit |
|-----------------------|------------------------------------|--|-----|-----|--------------------|-----|------|
| t _{TLH} | LOW to HIGH output transition time | VBUS; $V_{I(VIN)}$ = 5.0 V; C_L = 10 µF; R_L = 100 Ω ; see <u>Figure 12</u> and <u>Figure 13</u> | | | | | |
| | | V _{I(FO)} = GND | | - | 1.5 | - | ms |
| | | V _{I(FO)} = 5.0 V | | - | 50 | 100 | μs |
| t _{THL} | HIGH to LOW output transition time | VOUT; C _L = 10 μ F; R _L = 100 Ω ; see Figure 12 and Figure 13 | | | | | |
| | | V _{I(VIN)} = 5.0 V | | - | 2.2 | - | ms |
| t _{en} | enable time | EN to VOUT; $C_L = 10 \ \mu$ F; $R_L = 100 \ \Omega$; see <u>Figure 14</u> and <u>Figure 15</u> | | | | | |
| | | V _{I(VIN)} = 5.0 V; V _{I(FO)} = GND | | - | 0.75 | - | ms |
| | | V _{I(VIN)} = 5.0 V; V _{I(FO)} = 5.0 V | | - | 60 | - | μs |
| t _{dis} | disable time | EN to VOUT; $V_{I(VIN)}$ = 5.0 V; C_L = 10 µF; R _L = 100Ω; see <u>Figure 16</u> and <u>Figure 17</u> | | - | 90 | - | μs |
| t _{on(RCP)} | RCP recovery time | $V_{I(VIN)}$ = 5.0 V; EN = HIGH; From VBUS drops below VIN to FET-B ON; C _L = 10 µF | | - | 15 | 50 | μs |
| t _{dis(RCP)} | RCP turn off time | FET-B RCP turn OFF time | [2] | - | 0.3 | - | μs |
| t _{degl} | deglitch time | \overline{FLT} in OCP; $V_{I(VIN)} = 5 V$; see <u>Figure 20</u> to <u>Figure 21</u> | | - | 8 | - | ms |

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 Table 13. Dynamic characteristics...continued

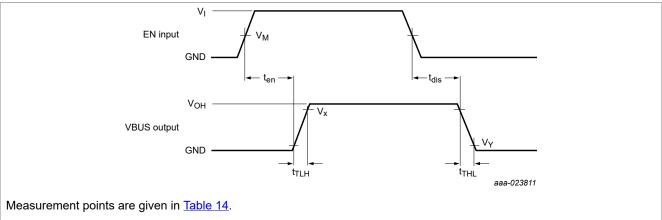
At recommended operating conditions; $V_{I(VIN)} = V_{I(EN)}$, $R_{FAULT} = 10 \text{ k}\Omega$ unless otherwise specified; voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | Min | Typ ^[1] | Max | Unit |
|-------------------------|--|---|-----|--------------------|-----|------|
| t _{short(OCP)} | OCP short circuit protection response time | V _{I(VIN)} = 5.0 V; C _{BUS} =10 μF; Measure current at VBUS side | - | 5 | - | μs |

[1] Typical values are measured at $T_j = 25 \text{ °C}$.

[2] Guaranteed by design

14.1 Waveform and test circuits

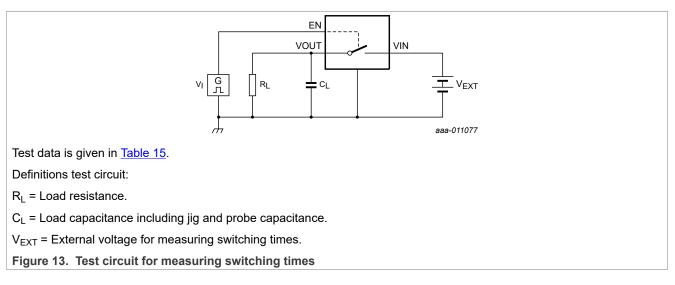


Logic level: V_{OH} is the typical output voltage that occurs with the output load.

Figure 12. Switching times and rise and fall times

Table 14. Measurement points

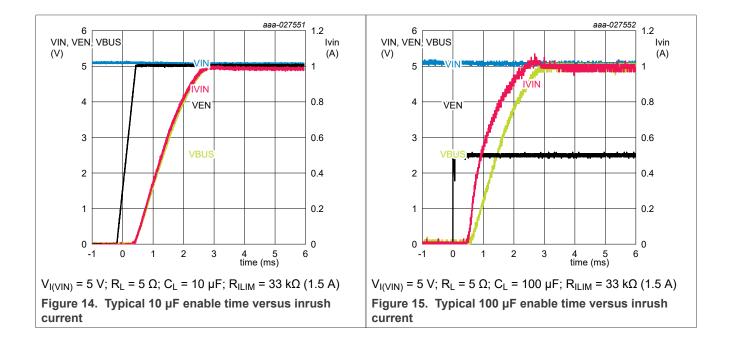
| Supply voltage | EN Input | Output | |
|---------------------|------------------------|-----------------------|-----------------------|
| V _{I(VIN)} | V _M | V _X | V _Y |
| 5.0 V | $0.5 \times V_{I(EN)}$ | 0.9 × V _{OH} | 0.1 × V _{OH} |

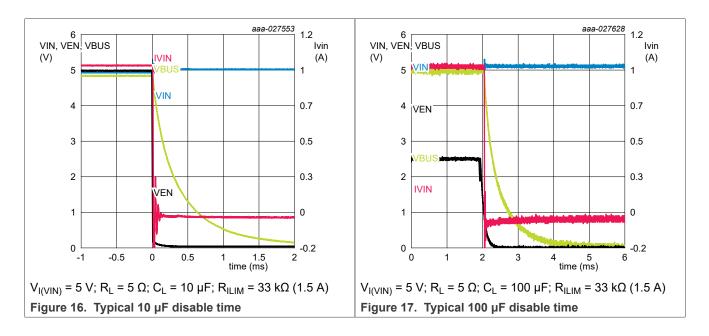


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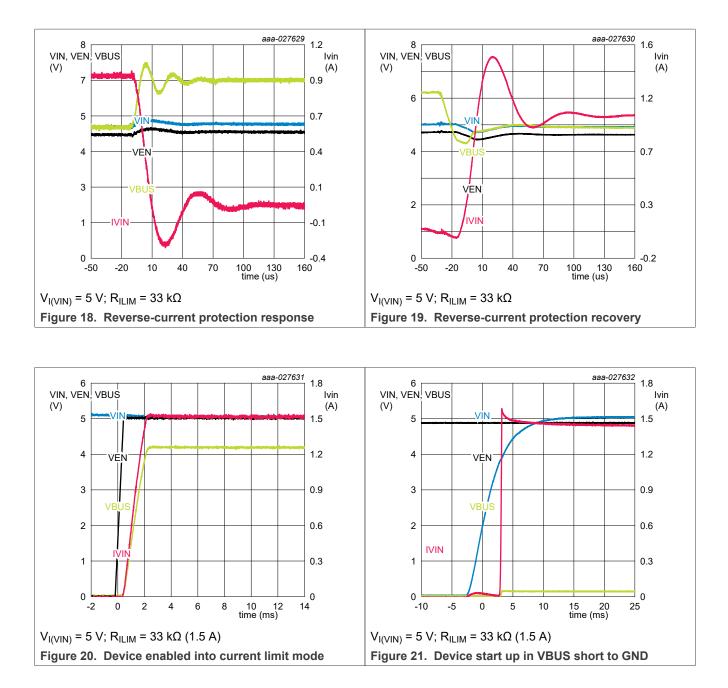
| Table 15. Test data | | | | |
|---------------------|--------------------------|-------|-------|--|
| Supply voltage | EN Input | Load | | |
| V _{EXT} | V _{I(EN)} | CL | RL | |
| 5.0 V | 0 to V _{I(VIN)} | 10 µF | 100 Ω | |





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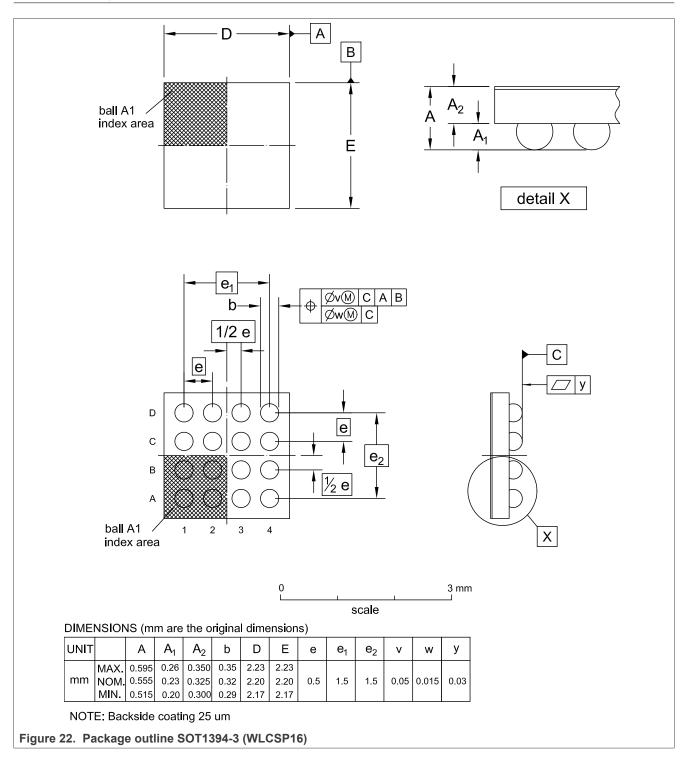
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15 Package outline



NX5P3363_Q100 Product data sheet

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16 Abbreviations

| Table 16. Abbreviations | | |
|-------------------------|-------------------------|--|
| Acronym | Description | |
| ESD | ElectroStatic Discharge | |
| CDM | Charged Device Model | |
| НВМ | Human Body Model | |
| USB | Universal Serial Bus | |

17 Revision history

Table 17. Revision history

| Document ID | Release date | Description |
|---------------------|--------------|-----------------|
| NX5P3363_Q100 v.1.0 | 31 May 2024 | Initial version |

USB PD and Type-C current-limited power switch

Legal information

Data sheet status

| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Product data sheet

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